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TEST REPORT For FCC

Frat Danast Ma		200005000
Гest Report No.	•	2008050022
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Date of Issue : May 19, 2008

FCC ID : QJCH332B

Model/Type No. : H332B

Kind of Product : Braille PDA

Applicant : HIMS Co., Ltd.

Applicant Address : 139-9, Gajung-dong, Yuseong-gu, Daejeon, KOREA

Manufacturer : HIMS Co., Ltd.

Manufacturer Address : 139-9, Gajung-dong, Yuseong-gu, Daejeon, KOREA

Contact Person : II Hyung, Kim / Team Leader

Telephone : +82-42-864-4460

Received Date : April 21, 2008

Test period : Start : April 21, 2008 End : May 19, 2008

Test Results : Not in Compliance

The test results presented in this report relate only to the object tested.

Tested by

Eun-Won, Lee Test Engineer

Date: May 19, 2008

Reviewed by

Young-Joon, Park
Technical Manager

Date: May 19, 2008

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REPORT REVISION HISTORY

Date	Revision	Page No
May 19, 2008	Issued (2008050022)	All

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1.0 General Product Description

Equipment model name : H332B

Serial number : Prototype

EUT condition : Pre-production, not damaged

Antenna type : Chip antenna Gain OdBi

Frequency Range : 2402 ~ 2480 MHz

RF output power Range : -6 dBm ~ +4 dBm (Class 2)

RF power : -0.23dBm - Conducted

Number of channels : 79

Channel Spacing : 1MHz

Channel Access Protocol : Frepuency Hopping

Type of Modulation : GFSK

Power Source : Internal Lithium ion Battery (DC 3.7V)

1.1 Tested Frequency

	LOW	MID	HIGH
Frequency (MHz)	2402	2441	2480

1.2 Model Differences

Not applicable

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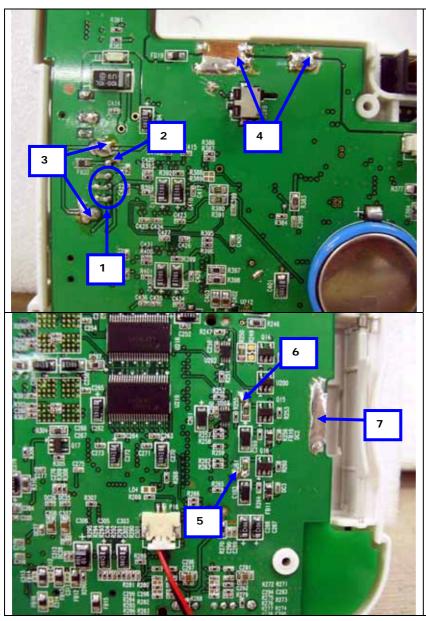
Form No.: CTK-RF-EF-Part15 SubpartC(Rev.2)



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1.3 Device Modifications

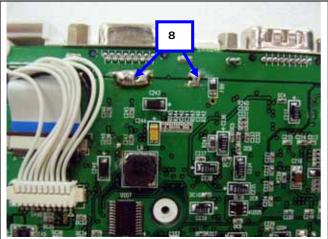
The following modifications were necessary for compliance:

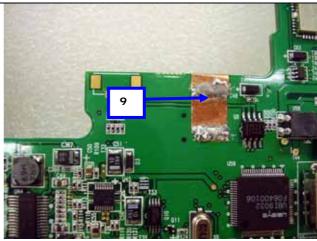


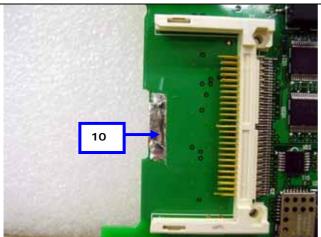
- 1) Inserted a capacitor 51 pF in pin 1, 2, 3 of a USB port.
- 2) Inserted a capacitor 100 nF in pin 4 of a USB port between the system ground.
- 3) Connected pin 5, 6 of a USB port (Flame ground) to the system ground.
- 4) Expansion of the Main Board ground.
- 5) Inserted capacitor 100 nF in R261 between the ground.
- 6) Inserted capacitor 100 nF in R254 between the ground.
- 7) Expansion of the Main Board ground.

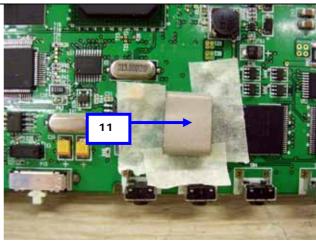
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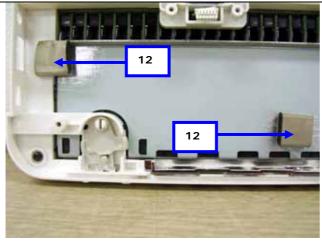


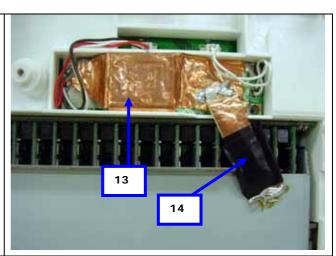
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- 8) Expansion of the Main Board ground.
- 9~10) Expansion of the Main Board ground. (Copper Tape)
- 11) Expansion of the Main Board ground. (Conductive Gasket)

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- 12) Attached Conductive Gasket on Chassis.
- 13) Attached Copper Tape on DC to DC Converter.
- 14) Attached Copper Tape and Isolation Tape on DC to DC converter between Chassis.
- 15) Ferrite core in USB cable [E-TECH-Part No.: CU0530GA]

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1.4 Peripheral Devices

Device	Manufacturer	Model No.	Serial No.	FCC ID or DoC
Personal Computer	SAMSUNG ELECTRONICS Co., Ltd.	DM-V55	516H96AL900727B	DoC
USB Mouse	MICROSOFT CORPORATION	Optical Mouse USB/PS2 Compatible	69657-492-4974533-40420	DoC
PS/2 Mouse	KYE SYSTEMS CORP.	N3+ Optical	K045205991	DoC
PS/2 Keyboard	Samsung Electro-Mechanics Co., Ltd.	SEM-DT35	33008101	DoC
LCD Monitor	LG Electronics	L17NS-A	612KGQN0J740	DoC
LCD Monitor	BENQ CORPORATON	E176FPb	CN-OKC139-46633-61J-6TWU	DoC
Headset	-	-	-	-

1.5 Calibration Details of Equipment Used for Measurement

Test equipment and test accessories are calibrated on regular basis. The maximum time between calibrations is one year or what is recommended by the manufacturer, whichever is less. All test equipment calibrations are traceable to the Korea Research Institute of Standards and Science (KRISS), therefore, all test data recorded in this report is traceable to KRISS.

1.6 Test Facility

The measurement facility is located at 386-1, Ho-dong, Cheoin-gu, Yongin-si, Gyeonggi-do, 449-100, Korea.

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Laboratory Accreditations and Listings

Country	Agency	Scope of Accreditation	Logo
USA	FCC	3 & 10 meter Open Area Test Sites and one conducted site to perform FCC Part 15/18 measurements.	FC 93250
JAPAN	VCCI	10 meter Open Area Test Site and one conducted site.	VCI R-948, C-986
KOREA	MIC	EMI (10 meter Open Area Test Site and two conducted sites) EMS (ESD, RS, EFT/Burst, Surge, CS, Magnetic, Dips and interruptions)	No. 51, KR0025
International	KOLAS	EMC	KOLAS DE PESTING NO. 198 SES
Europe	GLAS	EMC EN 55011, EN 55022, EN 61000-6-3, EN 61000-6-4, EN 61000-3-2, EN 61000-3-3, EN 61000-6-1, EN 61000-6-2, EN 50130-4, EN 55024, EN 61204-3, EN 60601-1-2, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, EN 61000-4-8, EN 61000-4-11	TÜV No.13000796-02

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2.0 Summary of tests

FCC Part Section(s)	Parameter	Limit	Test Condition	Status (note 1)
15.247(a)	Carrier Frequency Separation	> 25 kHz	Conducted	С
15.247(a)	Number of Hopping Frequencies	> 75 hops		С
15.247(a)	20 dB Bandwidth	< 1 MHz		С
15.247	Dwell Time	< 0.4 seconds		С
15.247(b)	Transmitter Output Power	< 1Watt		С
15.247(d)	Conducted Spurious emission	> 20 dBc		С
15.247(d)	Band Edge	> 20 dBc		С
15.249 /15.209	Field Strength of Harmonics	< 54 dBuV (at 3m)	Radiated	С
15.207 /15.107	AC Conducted Emissions	EN 55022	Line Conducted	С

<u>Note 1</u>: C=Complies NC=Not Complies NT=Not Tested NA=Not Applicable

Note 2: The data in this test report are traceable to the national or international standards.

The sample was tested according to the following specification:

- FCC Part 15.247, ANSI C63.4-2003

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2.1 Transmitter Requirements

2.1.1 Carrier Frequency Separation

Test Location

RF Test Room

Test Procedures

The carrier frequency separation was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function enabled.

After the trace being stable, the reading value between the peaks of the adjacent channels using the marker-delta function was recorded as the measurement results.

The spectrum analyzer is set to:

Span = 3 MHz (wide enough to capture the peaks of two adjacent channels)

RBW = 30 kHz (1% of the span) Sweep = auto

VBW = 30 kHz (RBW) Detector function = peak

Trace = max hold

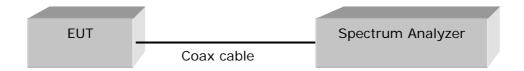


Figure 1: Measurement setup for the carrier frequency seperation

Limit

The EUT shall have hopping channel carrier frequencies separated minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

Test Results

Carrier Frequency Separation (MHz)	Result
1.002	Complies

See next pages for actual measured spectrum plots.

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Carrier Frequency Separation



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2.1.2 Number of Hopping Frequencies

Test Location

RF Test Room

Test Procedures

The number of hopping frequencies was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function enabled.

The spectrum analyzer is set to:

Frequency range 1:Start = 2389.5 MHz, Stop = 2439.5 MHz

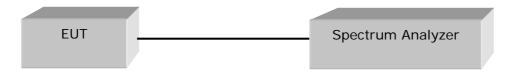
2:Start = 2439.5 MHz, Stop = 2489.5 MHz

Span = 50 MHz

RBW = 300 kHz (1% of the span) Sweep = auto

VBW = 300 kHz (RBW) Detector function = peak

Trace = max hold



Limit

The EUT in the 2400-2483.5 MHz band shall use at least 75 channels.

Test Results

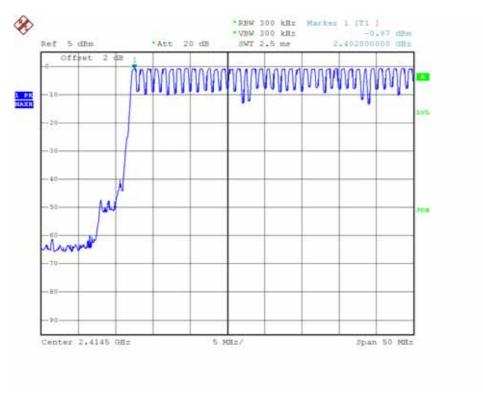
Total number of Hopping Channels	Result
79	Complies

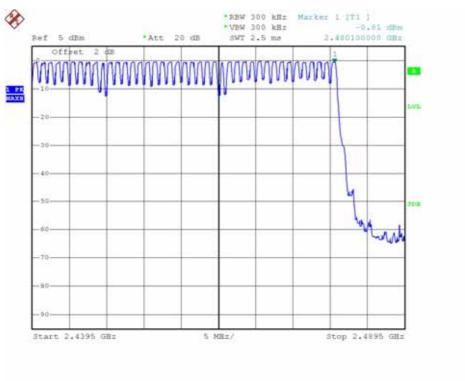
See next pages for actual measured spectrum plots.

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Number of Hopping Frequencies





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2.1.3 20 dB bandwidth

Test Location

RF Test Room

Test Procedures

The bandwidth at 20 dB below the highest inband spectral density was measured with a spectrum analyzer connected to the antenna terminal, while EUT had its hopping function disabled at the highest, middle and the lowest available channels. After the trace being stable, Use the marker-to peak function to set the marker to the peak of the emission. Use the marker-delta function to measure 20 dB down one side of the emission. Reset the marker-delta function, and move the marker to the other side of the emission, until it is (as close as possible to) even with the reference marker level. The marker-delta reading at this point is the 20 dB bandwidth of the emission.

The spectrum analyzer is set to:

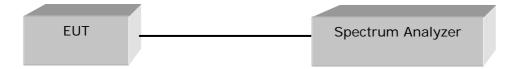
Center frequency = the highest, middle and the lowest channels

Span = 2 MHz (approximately 2 or 3 times of the 20 dB bandwidth)

RBW = 30 kHz (1% of the span) Sweep = auto

VBW = 30 kHz (RBW) Detector function = peak

Trace = max hold



Limit

The Transmitter shall have a maximum 20 dB bandwidth of 1 MHz.

Test Results

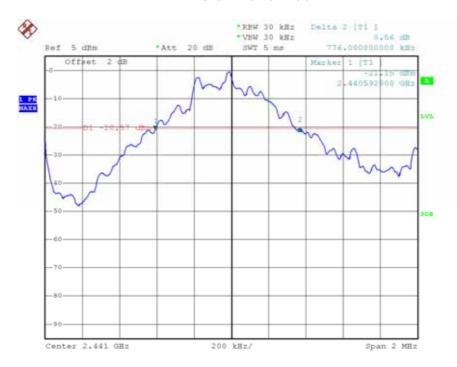
Frequency (MHz)	Channel Number.	Measured Bandwidth (MHz)	Result
2441	0	0.776	Complies

See next pages for actual measured spectrum plots. (worst case)

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20 dB Bandwidth



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2.1.4 Time of Occupancy (Dwell Time)

Test Location

RF Test Room

Test Procedures

The dwell time was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function enabled.

The spectrum analyzer is set to:

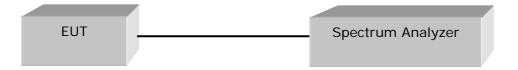
Center frequency = the highest, middle, and the lowest channels

Span = zero

RBW = 1 MHz Trace = max hold

VBW = 1 MHz (RBW) Detector function = peak

Sweep = as necessary to capture the entire dwell time per hopping channel



Limit

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

Test Results

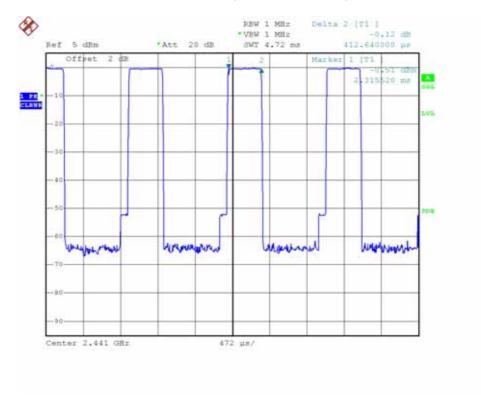
Channel	Channel Frequency	Packet Type	Test Results	
Number	(MHz)	r doket Type	Dwell Time (ms)	Result
39 2441	DH 1	132.09	Complies	
	2441	DH 3	271.88	Complies
		DH 5	310.74	Complies

See next pages for actual measured spectrum plots. (Worst case)

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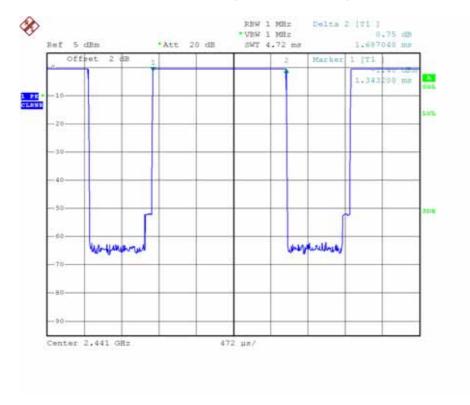
Time of Occupancy for PACKET Type DH 1



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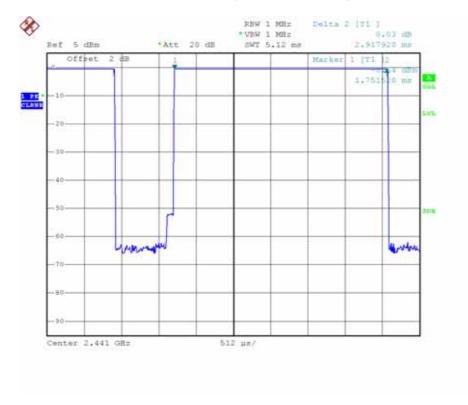
Time of Occupancy for PACKET Type DH 3



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Time of Occupancy for PACKET Type DH 5



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2.1.5 Maximum peak Conducted Output Power

Test Location

RF Test Room

Test Procedures

The maximum peak conducted output power was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function disabled at the highest, middle and the lowest available channels.

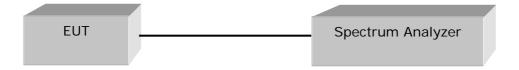
The spectrum analyzer is set to:

Center frequency = the highest, middle, and the lowest channels Span = 5 MHz (approximately 5 times of the 20 dB bandwidth)

RBW = 1 MHz (greater than the 20 dB bandwidth of the emission being measured)

VBW = 1 MHz (RBW) Detector function = peak

Trace = \max hold Sweep = auto



Limit

< 1 W

Test Results

Frequency (MHz)	Channel No.	Peak output power(dBm)	Peak output power(mW)	Result
2402	0	-0.46	0.899	Complies
2441	39	-0.33	0.927	Complies
2480	78	-0.23	0.948	Complies

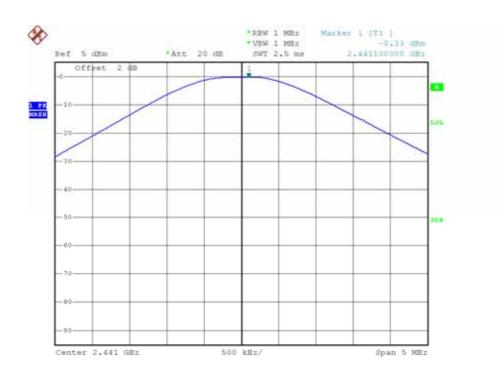
See next pages for actual measured spectrum plots.

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Maximum peak Conducted Output Power





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2.1.6 Band-edge

Test Location

RF Test Room

Test Procedures

The bandwidth at 20 dB down from the highest inband spectral density was measured with a spectrum analyzer connected to the antenna terminal, while EUT has its hopping function disabled at the highest, middle and the lowest available channels.

The spectrum analyzer is set to:

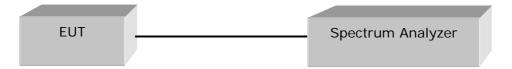
Center frequency = the highest, middle, and the lowest channels

RBW = 100 kHz

VBW = 100 kHz (RBW)

Span = 100 MHz Detector function = peak

Trace = \max hold Sweep = auto



Limit

> 20 dBc

Test Results

All conducted emission in any 100 kHz bandwidth outside of the spectrum band was at least 20 dB lower than the highest inband spectral density.

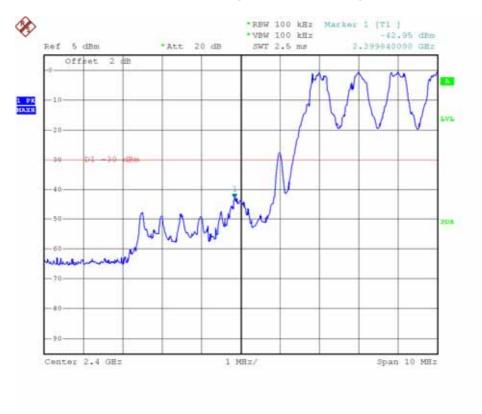
Therefore the applying equipment meets the requirement.

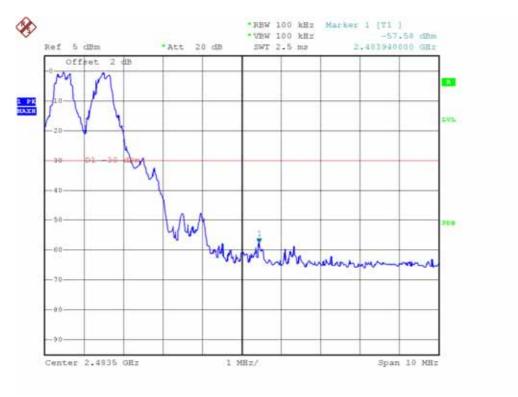
See next pages for actual measured spectrum plots.

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Band - edge (with Hopping)

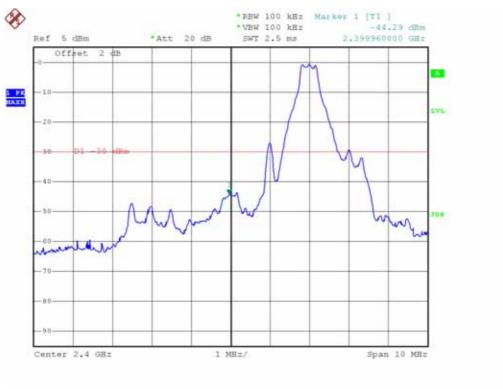


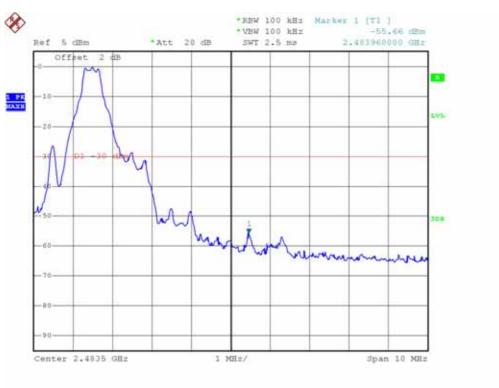


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Band - edge (without Hopping)





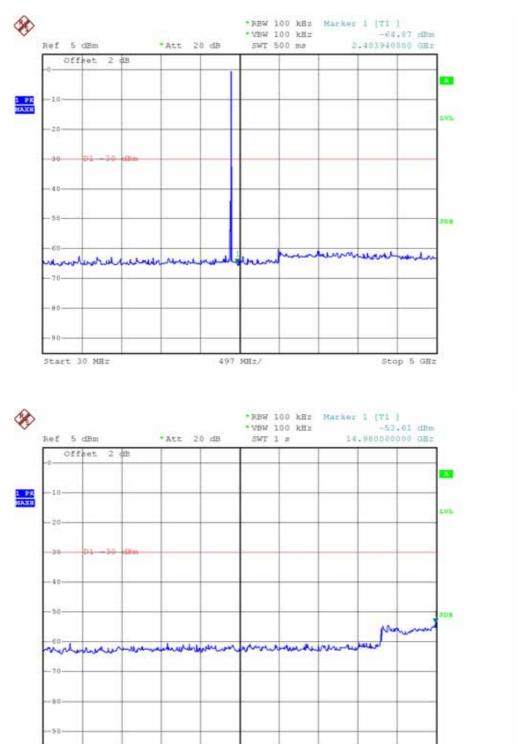
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Band – edge (at 20 dB blow) – Low channel Frequency Range = 30 MHz ~ 10th harmonic



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Start 5 GHz

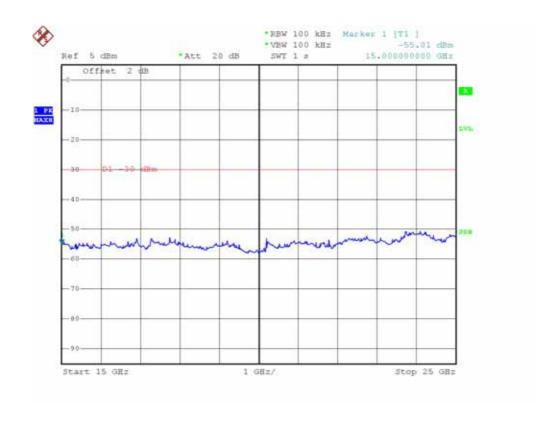
Date: May 19, 2008

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Stop 15 GH:

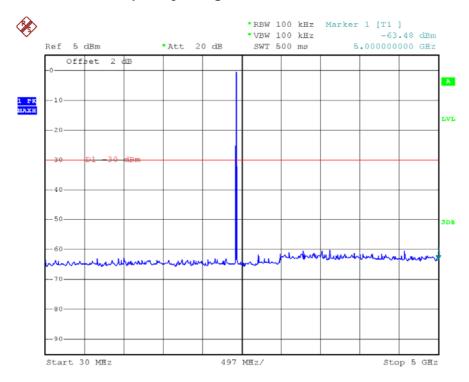


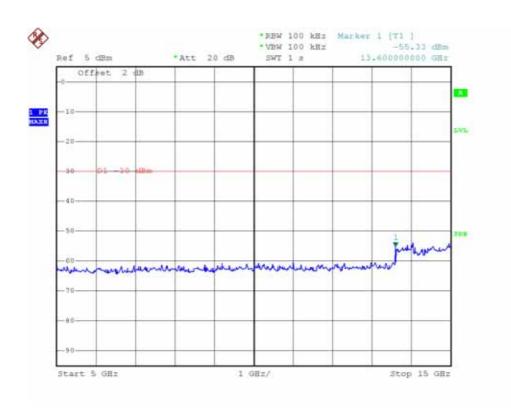


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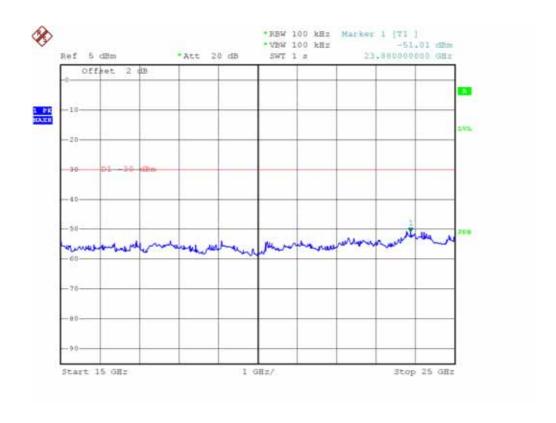
Band – edge (at 20 dB blow) – Mid channel Frequency Range = 30 MHz ~ 10th harmonic





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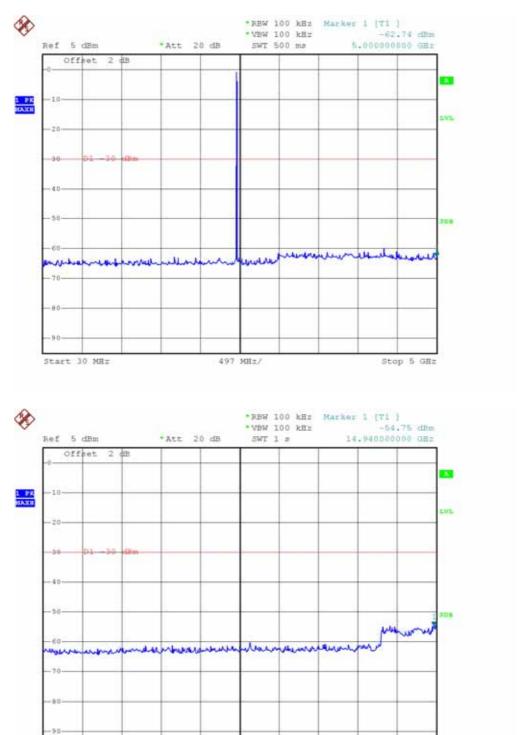




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Band – edge (at 20 dB blow) – High channel Frequency Range = 30 MHz ~ 10th harmonic



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Start 5 GHz

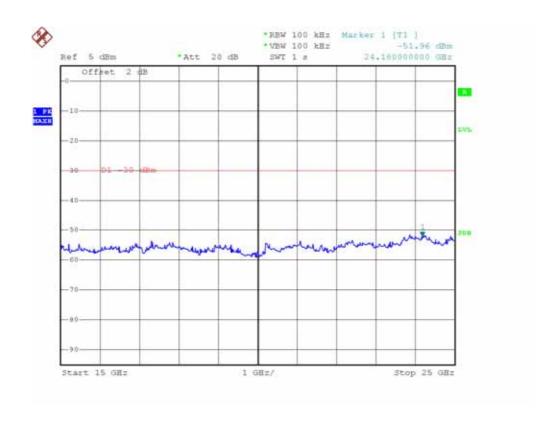
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Stop 15 GH:





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2.1.7 Field Strength of Emissions

Test Location

☐ Testing was performed at a test distance of 3 meter Open Area Test Site

Test Procedures

The height of the measuring antenna was varied between 1 to 4 m and the table was rotated a full revolution in order to obtain maximum values of the electric field intensity. The measurement was made in both the vertical and horizontal polarization, and the maximum value is presented in the report.

The spectrum analyzer is set to:

Center frequency = the worst channel

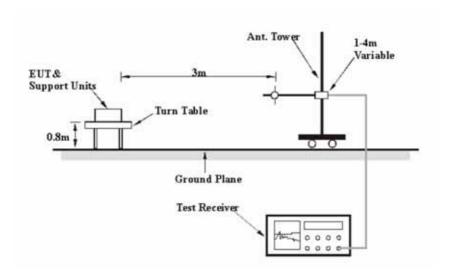
Frequency Range = 30 MHz ~ 10th harmonic

RBW = 120 kHz (30 MHz ~ 1 GHz) VBW RBW

= 1 MHz (1 GHz ~ 10th harmonic)

Span = 100 MHz Detector function = Quasi-peak

Trace = max hold



Limit

- 15.209(a)

	101203 (4)				
	Frequency(MHz)	Field Strength uV/m@3m	Field Strength dBuV/m@3m		
ĺ	30-88	100**	40		
ĺ	88-216	150**	43.5		
Ī	216-960	200**	46		
ĺ	Above 960	500	54		

^{**} Except as provided in 15.209(g).fundamental emissions from intentional radiators operating under this Section shall not be located in the frequency bands 54-72MHz, 76-88MHz, 174-216MHz, 470-806MHz. However, operation within these frequency bands is permitted under other sections of this Part, e.g.15.231 and 15.241.

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Test Results

EUT	Braille PDA	Measurement Detail			
Model	H332B	Frequency Range Below 1000MHz			
Channel	-	Detector function	Quasi-Peak		

The requirements are:

Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
347.50	42.5	3.5	Quasi-Peak

Test Data

Frequency	Reading	Pol.	Height		Correction Factor		Result	Margin
[MHz]	[dBuV/m]		[m]	Antenna	Cable	[dBuV/m]	[dBuV/m]	[dB]
105.10	24.2	V	1.0	9.8	2.0	43.5	36.0	7.5
313.50	26.3	Н	2.0	11.3	4.5	46.0	42.1	3.9
340.15	24.1	V	2.0	12.2	4.7	46.0	41.0	5.0
347.50	25.3	Н	1.5	12.4	4.8	46.0	42.5	3.5
762.00	15.1	Н	1.9	19.5	7.4	46.0	42.0	4.0
798.25	12.3	Н	1.0	19.8	7.8	46.0	39.9	6.1

H: Horizontal, V: Vertical

Remark:

The field strength of spurious emission was measured in the following position: EUT stand-up position(Z axis), lie-down position(X,Y axis). The worst emission was found in stand-up position(Z axis) and the worst case was recorded.

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Test Results

EUT	Braille PDA	Measurement Detail			
Model	H332B	Frequency Range 1-25GHz			
Channel	Channel 0	Detector function	Peak		

Remarks

We have tested three mode (X, Y, Z). The worst mode (X axis) for final test.

The requirements are:

□ Complies

	Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
ſ	-	-	-	-

Test Data

Frequency	Reading		Height	Correction			Limits	Result	Margin
		Pol.			Factor				
[MHz]	[dBuV/m]		[m]	Antenna	Amp.Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]

No emission were detected at a level greater than 20dB below limit

Restricted band edge test data

Measured frequency range: 2310-2390 MHz, 2483.5-2500 MHz

	Frequency	Reading	Pol.	Height	Correction			Limits	Result	Margin
				rieigrit	Factor				110001	9
	[MHz]	[dBuV/m]	101.	[m]	Antenna	Amp. Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]
L						Gain				_

No emissions were detected at a level greater than 20dB below limit.

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Test Results

EUT	Braille PDA	PDA Measurement Detail			
Model	H332B	Frequency Range	1-25GHz		
Channel	Channel 39	Detector function	Peak		

Remarks

We have tested three mode (X, Y, Z). The worst mode (X axis) for final test.

The requirements are:

□ Complies

Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
_	-	-	

Test Data

Frequency Reading Pol.			Correction Height			Limits	Result	Margin	
. ,	J	Pol.	J		Factor				J
[MHz]	[dBuV/m]		[m]	Antenna	Amp.Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]

No emissions were detected at a level greater than 20dB below limit.

Restricted band edge test data

Measured frequency range: 2310-2390 MHz, 2483.5-2500 MHz

Frequency	Reading		Height	C	Correction Factor Amp.		Limits	Result	Margin
FB411-3	FalDr M (mall	Pol.	Fm-1	0			EdD: W (m. 1	FalDr M (mal	E-ID1
[MHz]	[dBuV/m]		[m]	Antenna	Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]

No emissions were detected at a level greater than 20dB below limit.

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Test Results

EUT	Braille PDA	Measurement Detail			
Model	H332B	Frequency Range	1-25GHz		
Channel	Channel 78	Detector function	Peak		

Remarks

We have tested three mode (X, Y, Z). The worst mode (X axis) for final test.

The requirements are:

□ Complies

<u> </u>			
Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark
(IVITZ)	(ubuv/III)	(ив)	
-	-	-	-

Test Data

Frequency	Reading		Height	Correction Factor		Limits Result		Margin	
		Pol.							
[MHz]	[dBuV/m]		[m]	Antenna	Amp.Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]

No emissions were detected at a level greater than 20dB below limit.

Restricted band edge test data

Measured frequency range: 2310-2390 MHz, 2483.5-2500 MHz

Frequency	Reading	Pol.	Height	Correction			Limits	Result	Margin
	J			Factor					
FB41.1-3	EdD: M (mal	101.	Free 7	0	Amp.	Cabla	EdD: W/mal	EdD: M /mal	[-ID]
[MHz]	[dBuV/m]		[m]	Antenna	Gain	Cable	[dBuV/m]	[dBuV/m]	[dB]

No emissions were detected at a level greater than 20dB below limit.

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2.1.8 AC Conducted Emissions

Test Location

Shielded Room

Frequency Range of Measurement

150 kHz to 30 MHz

Instrument Settings

IF Band Width: 9 kHz

Test Procedures

The EUT was placed on a non-metallic table 0.8m above the metallic, grounded floor and 0.4m from the reference ground plane wall. The distance to other metallic surfaces was at least 0.8m.

Amplitude measurements were performed with a quasi-peak detector and an average detector.

Limit

- 15.207(a)

Frequency	Conducted Limit (dBuV)					
(MHz)	Quasi-peak	Average				
0.15 ~ 0.5	66 to 56*	56 to 46*				
0.5 ~ 5	56	46				
5 ~ 30	60	50				

^{*} Decreases with the logarithm of the frequency.

Test Results

The requirements are:

□ Complies

Frequency (MHz)	Measured Data (dBuV/m)	Margin (dB)	Remark		
0.98	48.0	8.0	Quasi-peak		

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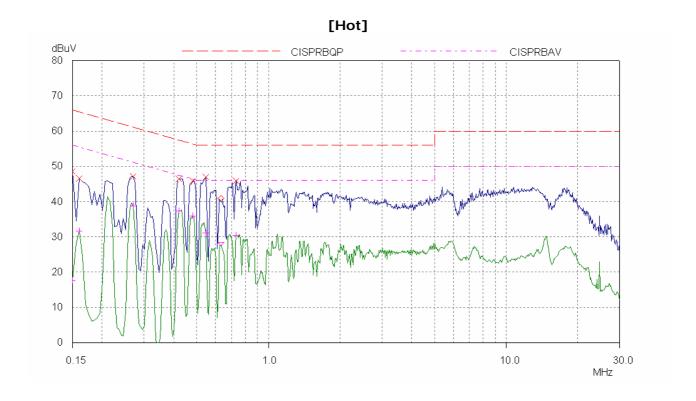
Test Data

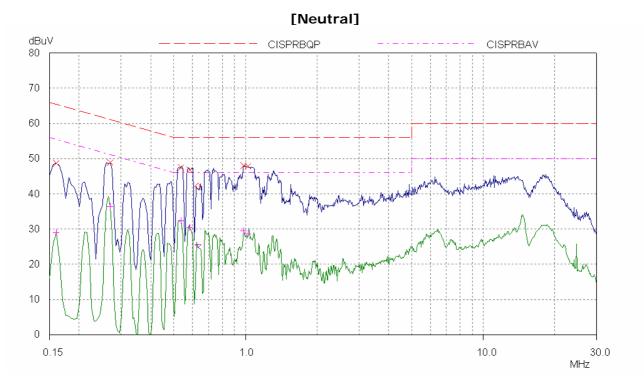
Frequency	Correction Factor				Quasi	-peak			Ave	rage	
. ,			Line	Limit	Reading	Result	Margin	Limit	Reading	Result	Margin
[MHz]	LISN	Cable		[dBuV]	[dBuV]	[dBuV]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
0.48	0.1	0.6	Н	56.3	45.2	45.9	10.4	46.3	35.2	35.9	10.4
0.53	0.1	0.6	N	56.0	46.7	47.4	8.6	46.0	31.6	32.3	13.7
0.54	0.1	0.6	Н	56.0	46.2	46.9	9.1	46.0	30.4	31.1	14.9
0.58	0.1	0.6	N	56.0	46.1	46.8	9.2	46.0	29.7	30.4	15.6
0.98	0.1	0.6	N	56.0	47.3	48.0	8.0	46.0	28.7	29.4	16.6
1.02	0.1	0.6	N	56.0	47.2	47.9	8.1	46.0	28.0	28.7	17.3

H: HOT, N: NEUTRAL

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APPENDIX A – Test Equipment Used For Tests

	Name of Equipment	Manufacturer	Model No.	Serial No.	Due Date
1	Spectrum Analyzer	Agilent	8564E	3551A0041	2008-11-01
2	Spectrum Analyzer	HP	E4403B	US39440619	2008-09-03
3	Spectrum Analyzer	Rohde & Schwarz	FSP-30	100994	2008-11-19
4	EMI Test Receiver	Rohde & Schwarz	ESVS30	826638/008	2009-03-07
5	ULTRA Broadband Antenna	Rohde & Schwarz	HL562	361324/014	2008-06-12
6	LOOP ANTENNA	EMCO	6502	9107-2652	2008-10-17
7	LOOP ANTENNA	EMCO	6502	9607-3020	2009-03-06
8	System Power Supply	HP	6032A	3440A-10521	2008-07-16
9	EPM Series Power Meter	HP	E4418A	GB38272734	2008-11-03
10	Power Sensor	HP	8481A	331BA92056	2008-11-03
11	Power Sensor	HP	8482B	331BA05406	2008-11-03
12	Audio Analyzer	HP	8903B	2747A03432	2008-11-01
13	ESG-D Series Signal Generator	Agilent	E4432B	US40054094	2008-11-01
14	SYNTHESIZED SWEEPER	HP	8341B	2819A01563	2008-11-22
15	Modulation Analyzer	HP	8901B	3438A05228	2008-11-08
16	Attenuator	HP	8494A	3308A33351	2008-11-06
17	Attenuator	HP	8496A	3308A15142	2008-11-06
18	Temp&Humi Chamber	Kunpoong	KP-1000	2002KP050041	2009-01-21
19	Temp&Humi Chamber	Kunpoong	KP-RC2000	2002KP650042	2009-01-21
20	EMC Analyzer	Agilent	E7405A	MY45110859	2008-01-09
21	Horn Antenna	ETS-Lindgren	3115	00078894	2008-11-29
22	Horn Antenna	ETS-Lindgren	3115	00078895	2008-11-29
23	Horn Antenna	ETS-Lindgren	3116	00062504	2008-11-27
24	Horn Antenna	ETS-Lindgren	3116	00062916	2008-11-27
25	Dipole Antenna	SCHWARZBECK	VHA 9103	VHA91032557	2009-11-27
26	Dipole Antenna	SCHWARZBECK	UHA 9105	UHA91052417	2009-11-27
27	OPT H64 AMPLIFIER	HP	8447F	3113A06814	2008-02-28
28	PREAMPLIFIER	Agilent	8449B	3008A02307	2008-11-05
29	Radio Communication Tester	Rohde & Schwarz	CMU200	106765	2009-02-09
30	Band Reject Filter	Wainwright Instruments	WRCG824	-	2009-04-16
31	Band Reject Filter	Wainwright Instruments	WRCG1750	-	2009-04-13

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Date: May 19, 2008

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